



## SSC8337GS1

### Dual P-Channel Enhancement Mode MOSFET

#### ➤ Features

V <sub>DS</sub>	V <sub>GS</sub>	R <sub>DS(ON)</sub> Typ.	I <sub>D</sub>
-30V	±20V	20mΩ@10V	-30A
		28mΩ@-4V5	

#### ➤ Description

This device is produced with high cell density DMOS trench technology, uses advanced trench technology and design to provide excellent R<sub>DS(ON)</sub> with low gate charge. This device particularly suits low voltage applications such as portable equipment, power management and other battery powered circuits, and low in-line power dissipation are needed in a very small outline surface mount package.

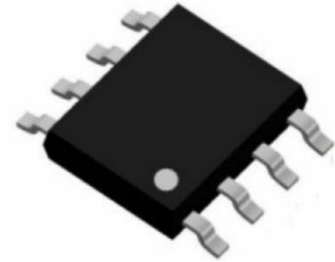
#### ➤ Applications

- NB Battery
- DC/DC Conversion
- Load Switch

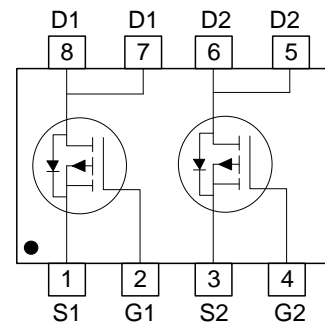
#### ➤ Ordering Information

Device	Package	Shipping
SSC8337GS1	SOP-8	2500/Reel

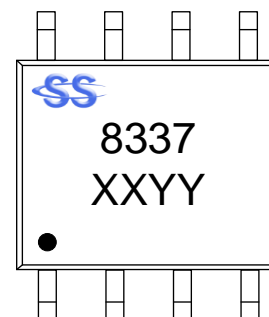
#### ➤ Pin configuration



**SOP-8 (Top View)**



**Pin Configuration**



**Marking**

(XXYY: Internal Traceability Code)



## ➤ Absolute Maximum Ratings ( $T_A=25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Ratings	Unit
$V_{DSS}$	Drain-to-Source Voltage	-30	V
$V_{GSS}$	Gate-to-Source Voltage	$\pm 20$	V
$I_D$	Continuous Drain Current <sup>d</sup>	$T_C=25^\circ\text{C}$	-30
		$T_C=100^\circ\text{C}$	-16.5
$I_{DSM}$	Continuous Drain Current <sup>a</sup>	$T_A=25^\circ\text{C}$	-9.3
		$T_A=70^\circ\text{C}$	-6.9
$I_{DM}$	Pulsed Drain Current <sup>b</sup>	-120	A
$P_D$	Power Dissipation <sup>c</sup>	$T_C=25^\circ\text{C}$	28
		$T_C=100^\circ\text{C}$	11.3
$P_{DSM}$	Power Dissipation <sup>a</sup>	$T_A=25^\circ\text{C}$	2.8
		$T_A=70^\circ\text{C}$	1.8
$I_{AS}$	Avalanche Current <sup>b</sup> $L=0.5\text{mH}$ Single Pulse	-19	A
$E_{AS}$	Avalanche Energy <sup>b</sup> $L=0.5\text{mH}$ Single Pulse	90	mJ
$T_J$	Operation junction temperature	-55~150	$^\circ\text{C}$
$T_{STG}$	Storage temperature range	-55~150	

## ➤ Thermal Resistance Ratings ( $T_A=25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Maximum	Unit
$R_{\theta JA}$	Junction-to-Ambient Thermal Resistance <sup>a</sup>	45	$^\circ\text{C}/\text{W}$
$R_{\theta JC}$	Junction-to-Case Thermal Resistance <sup>c</sup>	22	
	Junction-to-Case Thermal Resistance <sup>d</sup>	4.4	

Note:

- The value of  $R_{\theta JA}$  is measured with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz.copper, in a still air environment with  $T_A=25^\circ\text{C}$ . The value in any given application depends on the user is specific board design. The power dissipation is based on the  $t \leq 10\text{s}$  thermal resistance rating.
- Repetitive rating, pulse width limited by junction temperature.
- The power dissipation  $P_D$  is based on  $T_{J(\text{MAX})}=150^\circ\text{C}$ , using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heat sinking is used.

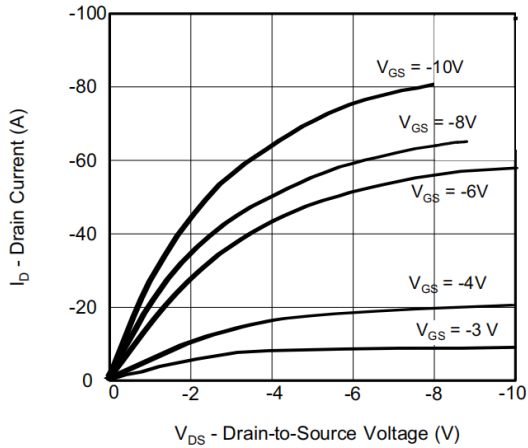


➤ **Electrical Characteristics (T<sub>A</sub>=25°C unless otherwise noted)**

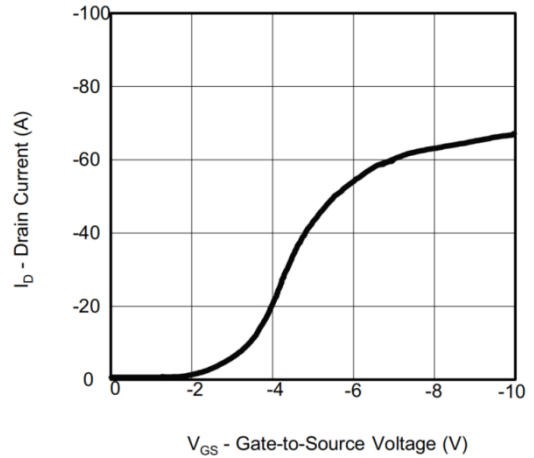
Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
Drain-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	V <sub>GS</sub> = 0V, I <sub>D</sub> = -250μA	-30			V
Gate Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = -250uA	-1	-1.8	-3	V
Drain-Source On-Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = -10V, I <sub>D</sub> = -10A		20	27	mΩ
		V <sub>GS</sub> = -4.5V, I <sub>D</sub> = -7A		28	37	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = -30V, V <sub>GS</sub> = 0V			-1	μA
Gate-Source Leak Current	I <sub>GSS</sub>	V <sub>GS</sub> = ±20V, V <sub>DS</sub> = 0V			±100	nA
Forward Voltage	V <sub>SD</sub>	V <sub>GS</sub> = 0V, I <sub>S</sub> = -5A			-1.3	V
Input Capacitance	C <sub>ISS</sub>	V <sub>DS</sub> = -15V, V <sub>GS</sub> = 0V, f = 1MHz		1275		pF
Output Capacitance	C <sub>OSS</sub>			161		
Reverse Transfer Capacitance	C <sub>RSS</sub>			183		
Total Gate Charge	Q <sub>G</sub>	V <sub>GS</sub> = -10V, V <sub>DS</sub> = -15V I <sub>D</sub> = -10A		25.6		nC
Gate to Source Charge	Q <sub>GS</sub>			4.2		
Gate to Drain Charge	Q <sub>GD</sub>			6.15		
Turn-on Delay Time	T <sub>D(ON)</sub>	V <sub>GS</sub> = -10V, V <sub>DS</sub> = -15V R <sub>L</sub> = 1Ω, R <sub>G</sub> = 3Ω		8.8		ns
Rise Time	T <sub>r</sub>			34.2		
Turn-off Delay Time	T <sub>D(OFF)</sub>			49.3		
Fall Time	T <sub>f</sub>			11		
Diode Recovery Time	T <sub>rr</sub>	I <sub>F</sub> =10A, di/dt=200A/us		22		ns
Diode Recovery Charge	Q <sub>rr</sub>	I <sub>F</sub> =10A, di/dt=200A/us		9		nC



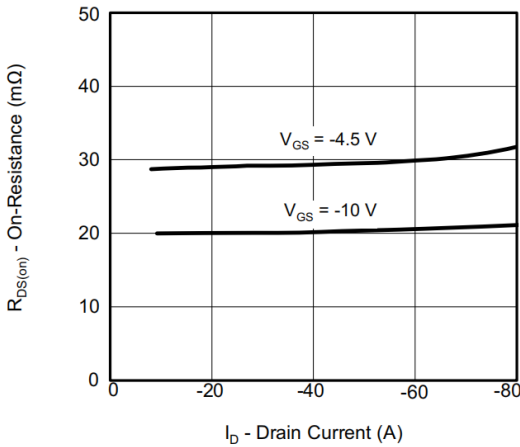
➤ **Typical Performance Characteristics ( $T_A=25^\circ\text{C}$  unless otherwise noted)**



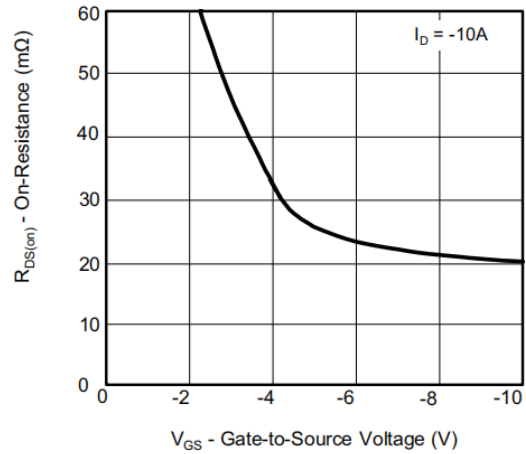
**Output Characteristics**



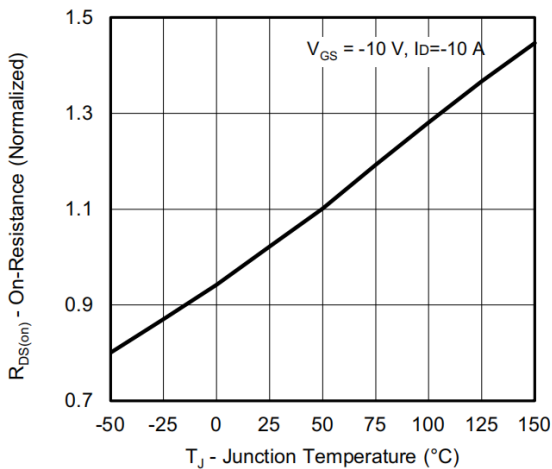
**Transfer Characteristics**



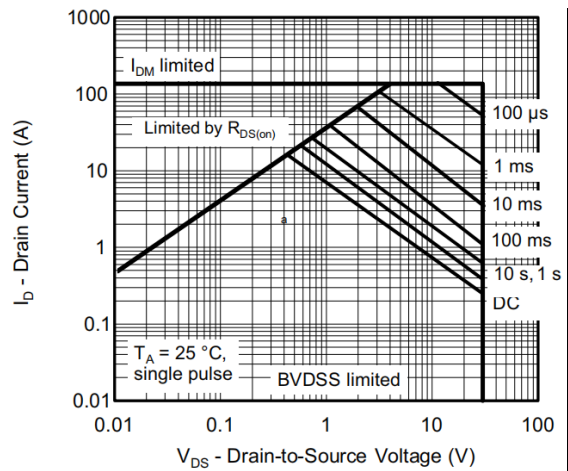
**On-Resistance vs. Drain Current and Gate Voltage**



**On-Resistance vs. Gate-to-Source Voltage**



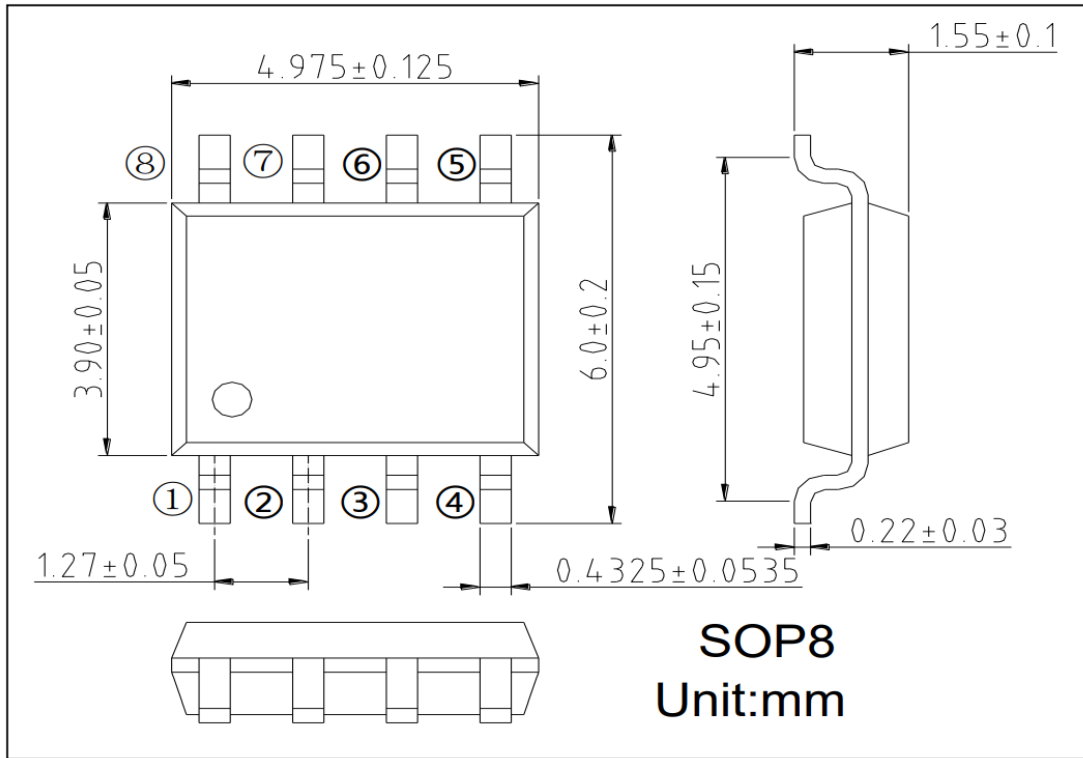
**On-Resistance vs. Junction Temperature**



**Safe Operating Area, Junction-to-Ambient**



## ➤ Package Information



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